

4.5A MOSFET Driver with Low Threshold Input and Enable

Features

- High Peak Output Current: 4.5A (typical)
- Wide Input Supply Voltage Operating Range:
 4.5V to 18V
- Low Shoot-Through/Cross-Conduction Current in Output Stage
- High Capacitive Load Drive Capability:
 2200 pF in 9.5 ns (typical)
- Short Delay Times: 16 ns (t_{D1}), 19.5 ns (t_{D2}) (typical)
- Low Supply Current: 355 μA (typical)
- Low-Voltage Threshold Input and Enable with Hysteresis
- Latch-Up Protected: Withstands 500 mA Reverse Current
- Space-Saving Packages:
 - 8-Lead MSOP
 - 8-Lead SOIC
 - 8-Lead 2 x 2 WDFN

Applications

- · Switch Mode Power Supplies
- Pulse Transformer Drive
- Line Drivers
- Level Translator
- · Motor and Solenoid Drive

General Description

The MCP14A0451/2 devices are high-speed MOSFET drivers that are capable of providing up to 4.5A of peak current while operating from a single 4.5V to 18V supply. There are two output configurations available; inverting (MCP14A0451) and noninverting (MCP14A0452). These devices feature low shoot-through current, fast rise and fall times, and short propagation delays which make them ideal for high switching frequency applications.

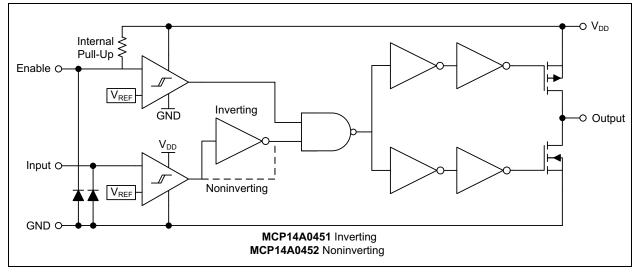
The MCP14A0451/2 family of devices offer enhanced control with Enable functionality. The active-high Enable pin can be driven low to drive the output of the MCP14A0451/2 low, regardless of the status of the Input pin. An integrated pull-up resistor allows the user to leave the Enable pin floating for standard operation.

These devices are highly latch-up resistant under any condition within their power and voltage ratings. They can accept up to 500 mA of reverse current being forced back into their outputs without damage or logic upset. All terminals are fully protected against electrostatic discharge (ESD) up to 2 kV (HBM) and 200V (MM).

Package Types

MCP14/ MSOP/		MCP14 MSOP	
VDD 1 IN 2 EN 3 GND 4	8 VDD 7 OUT 6 OUT 5 GND	VDD 1 IN 2 EN 3 GND 4	8 VDD 7 OUT 6 OUT 5 GND
MCP14 2 x 2 W		MCP14 2 x 2 W	
VDD 1 C EP IN 2 EP EN 3 9 GND 4	6 OUT 5 GND	VDD 1 0 IN 2 EF EN 3 9 GND 4	6 OUT 5 GND
* Includes Ex	kposed Therma	I Pad (EP); see T	able 3-1.

Functional Block Diagram



1.0 ELECTRICAL CHARACTERISTICS

1.1 Electrical Specifications

Absolute Maximum Ratings †

VDD, Supply Voltage	+20V
VIN, Input Voltage	(V _{DD} + 0.3V) to (GND - 0.3V)
VEN, Enable Voltage	(V _{DD} + 0.3V) to (GND - 0.3V)
Package Power Dissipation ($T_A = +50^{\circ}C$)	
8L MSOP	0.58W
8L SOIC	0.90W
8L 2 X 2 WDFN	1.63W
ESD protection on all pins	2 kV (HBM)
ESD protection on all pins	

† Notice: Stresses above those listed under "Maximum ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

TABLE 1-1: DC CHARACTERISTICS

Electrical Specifications: Unle		e noted, 1 _A –	125 0,	1000 ± 100		1
Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions
Input						
Input Voltage Range	V _{IN}	GND - 0.3V	_	V _{DD} + 0.3	V	
Logic '1' High Input Voltage	V _{IH}	2.0	1.6	-	V	
Logic '0' Low Input Voltage	V _{IL}	_	1.3	0.8	V	
Input Voltage Hysteresis	V _{HYST(IN)}	—	0.3	_	V	
Input Current	I _{IN}	-1	_	+1	μA	$0V \leq V_{IN} \leq V_{DD}$
Enable						
Enable Voltage Range	V _{EN}	GND - 0.3V	_	V _{DD} + 0.3	V	
Logic '1' High Enable Voltage	V _{EH}	2.0	1.6	_	V	
Logic '0' Low Enable Voltage	V _{EL}	_	1.3	0.8	V	
Enable Voltage Hysteresis	V _{HYST(EN)}	—	0.3	_	V	
Enable Pin Pull-Up Resistance	R _{ENBL}	_	1.5	_	MΩ	V _{DD} = 18V, ENB = A _{GND}
Enable Input Current	I _{EN}	_	12	_	μA	V _{DD} = 18V, ENB = A _{GND}
Propagation Delay	t _{D3}		15	22	ns	V _{DD} = 18V, V _{EN} = 5V, see Figure 4-3, (Note 1)
Propagation Delay	t _{D4}	_	20	27	ns	V _{DD} = 18V, V _{EN} = 5V, see Figure 4-3, (Note 1)
Output	1					
High Output Voltage	V _{OH}	V _{DD} - 0.025	_	—	V	I _{OUT} = 0A
Low Output Voltage	V _{OL}	_		0.025	V	I _{OUT} = 0A
Output Resistance, High	R _{OH}		1.6	2.6	Ω	I _{OUT} = 10 mA, V _{DD} = 18V
Output Resistance, Low	R _{OL}		1.2	2.2	Ω	I _{OUT} = 10 mA, V _{DD} = 18V
Peak Output Current	I _{PK}		4.5	_	А	V _{DD} = 18V (Note 1)
Latch-Up Protection Withstand Reverse Current	I _{REV}	0.5		—	A	Duty cycle \leq 2%, t \leq 300 µs (Note 1)
Switching Time (Note 1)						
Rise Time	t _R	_	9.5	14	ns	V_{DD} = 18V, C_L = 2200 pF, see Figure 4-1, Figure 4-2
Fall Time	t _F	_	9	14	ns	V _{DD} = 18V, C _L = 2200 pF, see Figure 4-1, Figure 4-2
Delay Time	t _{D1}	_	16	23	ns	V _{DD} = 18V, V _{IN} = 5V, see Figure 4-1, Figure 4-2
	t _{D2}	—	19.5	26.5	ns	V _{DD} = 18V, V _{IN} = 5V, see Figure 4-1, Figure 4-2
Power Supply	I				1	· · · · ·
Supply Voltage	V _{DD}	4.5		18	V	
	I _{DD}	_	355	580	μA	V _{IN} = 3V, V _{EN} = 3V
	I _{DD}	_	355	580	μA	$V_{IN} = 0V, V_{EN} = 3V$
Power Supply Current	I _{DD}	_	355	580	μA	$V_{IN} = 3V, V_{EN} = 0V$
	I _{DD}		355	580	μA	$V_{IN} = 0V, V_{EN} = 0V$

Note 1: Tested during characterization, not production tested.

Electrical Specifications: Un		İ	1			
Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions
Input						
Input Voltage Range	V _{IN}	GND - 0.3V	_	V _{DD} + 0.3	V	
Logic '1' High Input Voltage	V _{IH}	2.0	1.6	—	V	
Logic '0' Low Input Voltage	V _{IL}	—	1.3	0.8	V	
Input Voltage Hysteresis	V _{HYST(IN)}	—	0.3	—	V	
Input Current	I _{IN}	-10	—	+10	μA	$0V \leq V_{IN} \leq V_{DD}$
Enable						
Enable Voltage Range	V _{EN}	GND - 0.3V	—	V _{DD} + 0.3	V	
Logic '1' High Enable Voltage	V _{EH}	2.0	1.6	—	V	
Logic '0' Low Enable Voltage	V_{EL}	—	1.3	0.8	V	
Enable Voltage Hysteresis	V _{HYST(EN)}	_	0.3	_	V	
Enable Input Current	I _{EN}	—	12	—	μA	V _{DD} = 18V, ENB = A _{GND}
Propagation Delay	t _{D3}	—	19	26	ns	V_{DD} = 18V, V_{EN} = 5V, T_A = +125°C, see Figure 4-3
Propagation Delay	t _{D4}	—	24	31	ns	V_{DD} = 18V, V_{EN} = 5V, T_A = +125°C, see Figure 4-3
Output						
High Output Voltage	V _{OH}	V _{DD} - 0.025	—		V	DC Test
Low Output Voltage	V _{OL}	—	—	0.025	V	DC Test
Output Resistance, High	R _{OH}	_	_	3.5	Ω	I _{OUT} = 10 mA, V _{DD} = 18V
Output Resistance, Low	R _{OL}	—	—	3	Ω	I _{OUT} = 10 mA, V _{DD} = 18V

TABLE 1-2: DC CHARACTERISTICS (OVER OPERATING TEMP. RANGE)

Note 1: Tested during characterization, not production tested.

TABLE 1-2: DC CHARACTERISTICS (OVER OPERATING TEMP. RANGE) (CONTINUED)

Electrical Specifications: Unless otherwise indicated, over the operating range with $4.5V \le V_{DD} \le 18V$.

Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions
Switching Time (Note 1)						
Rise Time	t _R	_	11.5	16.5	ns	V_{DD} = 18V, C _L = 2200 pF, T _A = +125°C, see Figure 4-1, Figure 4-2
Fall Time	t _F	—	11.5	16.5	ns	$V_{DD} = 18V, C_L = 2200 \text{ pF},$ $T_A = +125^{\circ}\text{C}, \text{ see Figure 4-1},$ Figure 4-2
Delay Time	t _{D1}	—	20	27	ns	V_{DD} = 18V, V_{IN} = 5V, T_A = +125°C, see Figure 4-1, Figure 4-2
	t _{D2}	—	24.5	31.5		V_{DD} = 18V, V_{IN} = 5V, T_A = +125°C, see Figure 4-1, Figure 4-2
Power Supply					•	
Supply Voltage	V _{DD}	4.5	—	18	V	
	I _{DD}	_	—	700	uA	V _{IN} = 3V, V _{EN} = 3V
Power Supply Current	I _{DD}	—	—	700	uA	V _{IN} = 0V, V _{EN} = 3V
	I _{DD}	_	—	700	uA	V _{IN} = 3V, V _{EN} = 0V
	I _{DD}	_	—	700	uA	V _{IN} = 0V, V _{EN} = 0V

Note 1: Tested during characterization, not production tested.

1.2 Temperature Characteristics

Electrical Specifications: Unless otherwise noted, all parameters apply with $4.5V \le V_{DD} \le 18V$						
Parameter	Sym.	Min.	Тур.	Max.	Units	Comments
Temperature Ranges						
Specified Temperature Range	T _A	-40	_	+125	°C	
Maximum Junction Temperature	TJ	_		+150	°C	
Storage Temperature Range	T _A	-65	—	+150	°C	
Package Thermal Resistances						•
Junction-to-Ambient Thermal Resistance, 8LD MSOP	θ_{JA}		172	_	°C/W	Note 1
Junction-to-Ambient Thermal Resistance, 8LD SOIC	θ_{JA}	_	111		°C/W	Note 1
Junction-to-Ambient Thermal Resistance, 8LD WDFN	θ_{JA}	_	61		°C/W	Note 1
Junction-to-Top Characterization Parameter, 8LD MSOP	Ψ_{JT}	_	7		°C/W	Note 1
Junction-to-Top Characterization Parameter, 8LD SOIC	Ψ_{JT}	_	12		°C/W	Note 1
Junction-to-Top Characterization Parameter, 8LD WDFN	Ψ_{JT}	_	1.6		°C/W	Note 1
Junction-to-Board Characterization Parameter, 8LD MSOP		_	130	—	°C/W	Note 1
Junction-to-Board Characterization Parameter, 8LD SOIC	Ψ_{JB}	_	76		°C/W	Note 1
Junction-to-Board Characterization Parameter, 8LD WDFN	Ψ_{JB}	-	29		°C/W	Note 1

Note 1: Parameter is determined using High K 2S2P 4-Layer board as described in JESD 51-7, as well as JESD 51-5 for packages with exposed pads

2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

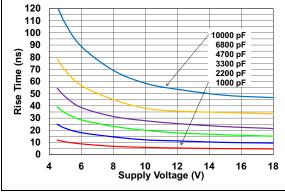


FIGURE 2-1: Rise Time vs. Supply Voltage.

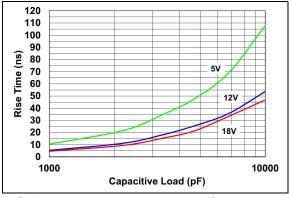
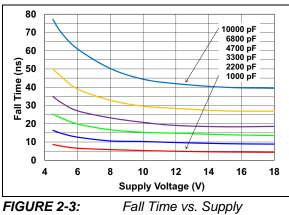


FIGURE 2-2: Rise Time vs. Capacitive Load.



Voltage.

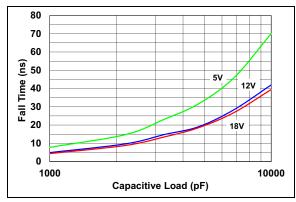


FIGURE 2-4: Fall Time vs. Capacitive Load.

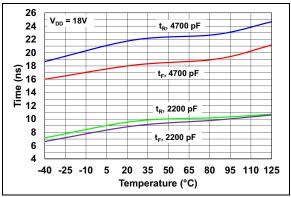
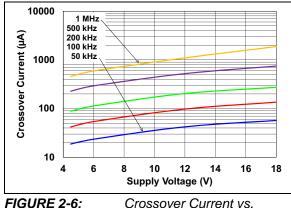


FIGURE 2-5: Rise and Fall Time vs. Temperature.



Supply Voltage.

Crossover Current vs.

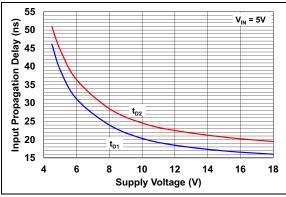


FIGURE 2-7: Input Propagation Delay vs. Supply Voltage.

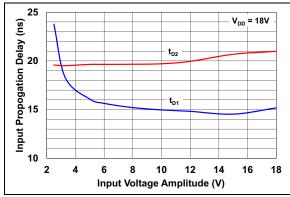


FIGURE 2-8: Input Propagation Delay Time vs. Input Amplitude.

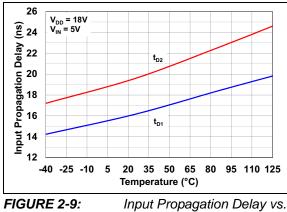


FIGURE 2-9: Temperature.

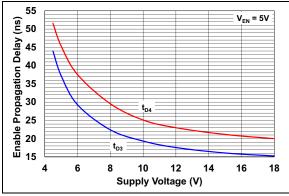


FIGURE 2-10: Enable Propagation Delay vs. Supply Voltage.

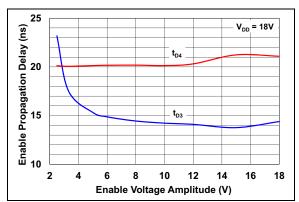


FIGURE 2-11: Enable Propagation Delay Time vs. Enable Voltage Amplitude.

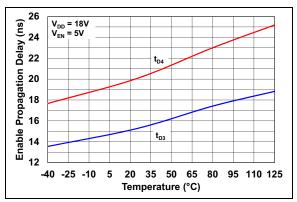
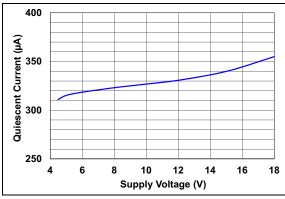
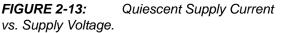


FIGURE 2-12: Enable Propagation Delay vs. Temperature.





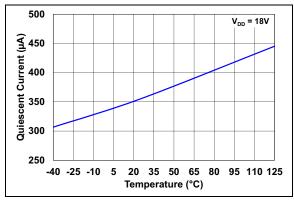


FIGURE 2-14: Quiescent Supply Current vs. Temperature.

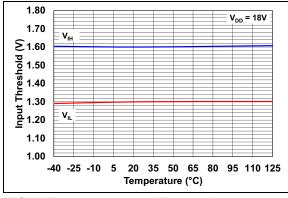


FIGURE 2-15: Input Threshold vs. Temperature.

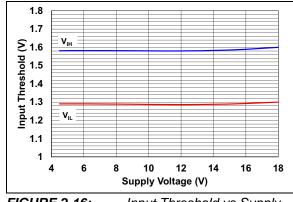


FIGURE 2-16: Input Threshold vs Supply Voltage.

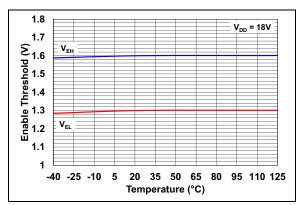


FIGURE 2-17: Enable Threshold vs. Temperature.

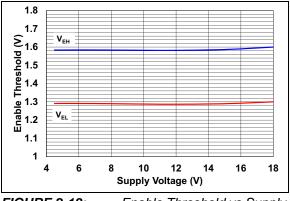


FIGURE 2-18: Enable Threshold vs Supply Voltage.

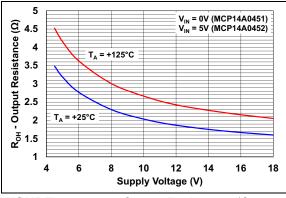


FIGURE 2-19: Output Resistance (Output High) vs. Supply Voltage.

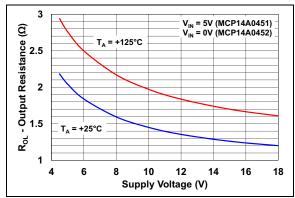


FIGURE 2-20: Output Resistance (Output Low) vs. Supply Voltage.

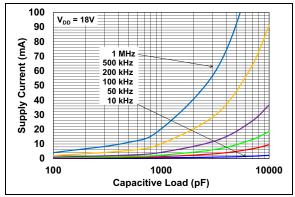


FIGURE 2-21: Supply Current vs. Capacitive Load ($V_{DD} = 18V$).

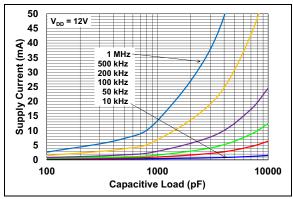


FIGURE 2-22: Supply Current vs. Capacitive Load ($V_{DD} = 12V$).

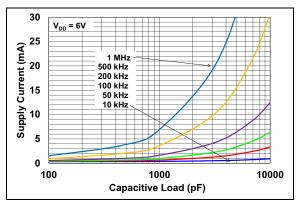


FIGURE 2-23: Supply Current vs. Capacitive Load ($V_{DD} = 6V$).

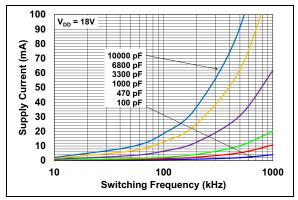


FIGURE 2-24: Supply Current vs. Frequency ($V_{DD} = 18V$).

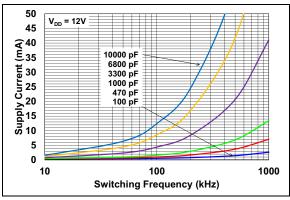


FIGURE 2-25: Supply Current vs. Frequency ($V_{DD} = 12V$).

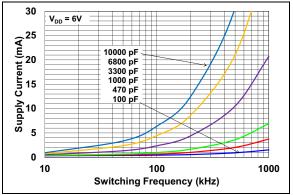


FIGURE 2-26: Supply Current vs. Frequency ($V_{DD} = 6V$).

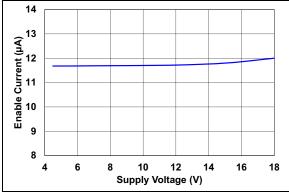


FIGURE 2-27: Enable Current vs. Supply Voltage.

NOTES:

3.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 3-1.

TABLE 3-1:	PIN FUNCTION TABLE

MCP14	A0451/2	Symbol	Description
8L 2 x 2 WDFN	8L MSOP/SOIC	Symbol	Description
1	1	V _{DD}	Supply Input
2	2	IN	Control Input
3	3	EN	Device Enable
4	4	GND	Power Ground
5	5	GND	Power Ground
6	6	OUT/OUT	Push-Pull Output
7	7	OUT/OUT	Push-Pull Output
8	8	V _{DD}	Supply Input
EP	—	EP	Exposed Thermal Pad (GND)

3.1 Output Pin (OUT, OUT)

The Output is a CMOS push-pull output that is capable of sourcing and sinking 4.5A of peak current $(V_{DD} = 18V)$. The low output impedance ensures the gate of the external MOSFET stays in the intended state even during large transients. This output also has a reverse current latch-up rating of 500 mA.

3.2 Power Ground Pin (GND)

GND is the device return pin for the input and output stages. The GND pin should have a low-impedance connection to the bias supply source return. When the capacitive load is being discharged, high peak currents will flow out of the ground pin.

3.3 Device Enable Pin (EN)

The MOSFET driver Device Enable is a highimpedance input featuring low threshold levels. The Enable input also has hysteresis between the high and low input levels, allowing them to be driven from slow rising and falling signals and to provide noise immunity. Driving the Enable pin below the threshold will disable the output of the device, pulling OUT/OUT low, regardless of the status of the Input pin. Driving the Enable pin above the threshold allows normal operation of the OUT/OUT pin based on the status of the Input pin. The Enable pin utilizes an internal pull up resistor, allowing the pin to be left floating for standard driver operation.

3.4 Control Input Pin (IN)

The MOSFET driver Control Input is a high-impedance input featuring low threshold levels. The Input also has hysteresis between the high and low input levels, allowing them to be driven from slow rising and falling signals and to provide noise immunity.

3.5 Supply Input Pin (V_{DD})

 V_{DD} is the bias supply input for the MOSFET driver and has a voltage range of 4.5V to 18V. This input must be decoupled to ground with a local capacitor. This bypass capacitor provides a localized low-impedance path for the peak currents that are provided to the load.

3.6 Exposed Metal Pad Pin (EP)

The exposed metal pad of the WDFN package is internally connected to GND. Therefore, this pad should be connected to a Ground plane to aid in heat removal from the package.

NOTES:

4.0 APPLICATION INFORMATION

4.1 General Information

MOSFET drivers are high-speed, high-current devices which are intended to source/sink high-peak currents to charge/discharge the gate capacitance of external MOSFETs or Insulated-Gate Bipolar Transistors (IGBTs). In high frequency switching power supplies, the Pulse-Width Modulation (PWM) controller may not have the drive capability to directly drive the power MOSFET. A MOSFET driver such as the MCP14A0451/2 family can be used to provide additional source/sink current capability.

4.2 MOSFET Driver Timing

The ability of a MOSFET driver to transition from a fullyoff state to a fully-on state is characterized by the driver's rise time (t_R), fall time (t_F) and propagation delays (t_{D1} and t_{D2}). Figure 4-1 and Figure 4-2 show the test circuit and timing waveform used to verify the MCP14A0451/2 timing.

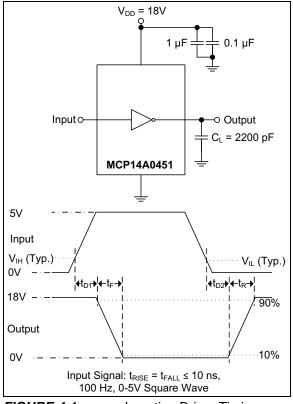
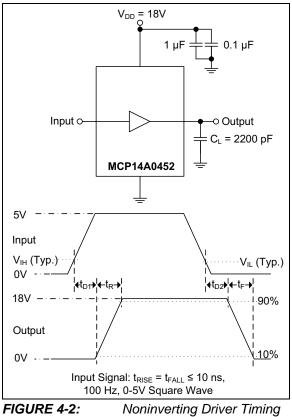


FIGURE 4-1: Inverting Driver Timing Waveform.



Waveform.

4.3 Enable Function

The enable pin (EN) provides additional control of the output pin (OUT). This pin is active high and is internally pulled up to V_{DD} so that the pin can be left floating to provide standard MOSFET driver operation.

When the enable pin's input voltage is above the enable pin high voltage threshold, (V_{EN_H}) , the output is enabled and allowed to react to the status of the Input pin. However, when the voltage applied to the Enable pin falls below the low threshold voltage (V_{EN_L}) , the driver's output is disabled and doesn't respond to changes in the status of the Input pin. When the driver is disabled, the output is pulled down to a low state. Refer to Table 4-1 for enable pin are similar to the threshold voltage levels for the Enable pin are similar to the threshold voltage levels of the Input pin. Hysteresis is provided to help increase the noise immunity of the enable function, avoiding false triggers of the enable signal during driver switching.

There are propagation delays associated with the driver receiving an enable signal and the output reacting. These propagation delays, t_{D3} and t_{D4} , are graphically represented in Figure 4-3.

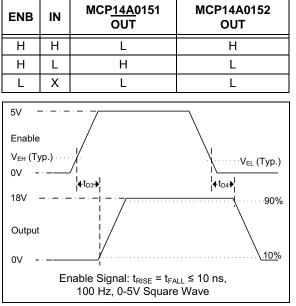


TABLE 4-1: ENABLE PIN LOGIC



4.4 Decoupling Capacitors

Careful PCB layout and decoupling capacitors are required when using power MOSFET drivers. Large current is required to charge and discharge capacitive loads quickly. For example, approximately 720 mA are needed to charge a 1000 pF load with 18V in 25 ns.

To operate the MOSFET driver over a wide frequency range with low supply impedance, it is recommended to place 1.0 μ F and 0.1 μ F low ESR ceramic capacitors in parallel between the driver V_{DD} and GND. These capacitors should be placed close to the driver to minimize circuit board parasitics and provide a local source for the required current.

4.5 PCB Layout Considerations

Proper Printed Circuit Board (PCB) layout is important in high-current, fast switching circuits to provide proper device operation and robustness of design. Improper component placement may cause errant switching, excessive voltage ringing or circuit latch-up. The PCB trace loop length and inductance should be minimized by the use of ground planes or traces under the MOSFET gate drive signal. Separate analog and power grounds and local driver decoupling should also be used.

Placing a ground plane beneath the MCP14A0451/2 devices will help as a radiated noise shield, as well as providing some heat sinking for power dissipated within the device.

4.6 **Power Dissipation**

The total internal power dissipation in a MOSFET driver is the summation of three separate power dissipation elements, as shown in Equation 4-1.

EQUATION 4-1:

Where:		$P_T = P_L + P_Q + P_{CC}$
P _T	=	Total power dissipation
P_L	=	Load power dissipation
P_Q	=	Quiescent power dissipation
P _{CC}	=	Operating power dissipation

4.6.1 CAPACITIVE LOAD DISSIPATION

The power dissipation caused by a capacitive load is a direct function of the frequency, total capacitive load and supply voltage. The power lost in the MOSFET driver for a complete charging and discharging cycle of a MOSFET is shown in Equation 4-2.

EQUATION 4-2:

Where:		$P_L = f \times C_T \times V_{DD}^2$
f	=	Switching frequency
CT	=	Total load capacitance
V_{DD}	=	MOSFET driver supply voltage

4.6.2 QUIESCENT POWER DISSIPATION

The power dissipation associated with the quiescent current draw depends on the state of the Input and Enable pins. See **Section 1.0 "Electrical Characteristics"** for typical quiescent current draw values in different operating states. The quiescent power dissipation is shown in Equation 4-3.

EQUATION 4-3:

$$P_{Q} = (I_{QH} \times D + I_{QL} \times (1 - D)) \times V_{DD}$$

Where:
$$I_{QH} =$$
Quiescent current in the High state
$$D =$$
Duty cycle
$$I_{QL} =$$
Quiescent current in the Low state
$$V_{DD} =$$
MOSFET driver supply voltage

4.6.3 OPERATING POWER DISSIPATION

The operating power dissipation occurs each time the MOSFET driver output transitions because, for a very short period of time, both MOSFETs in the output stage are on simultaneously. This cross-conduction current leads to a power dissipation described in Equation 4-4.

EQUATION 4-4:

Where:

$$P_{CC} = V_{DD} \times I_{CO}$$

I_{CO} = Crossover Current

V_{DD} = MOSFET driver supply voltage

NOTES:

5.0 PACKAGING INFORMATION

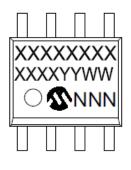
5.1 Package Marking Information



Part Number	Code
MCP14A0451-E/MS	A0451
MCP14A0451T-E/MS	A0451
MCP14A0452-E/MS	A0452
MCP14A0452T-E/MS	A0452

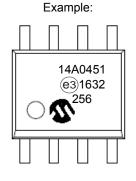


8-Lead SOIC



8-Lead WDFN

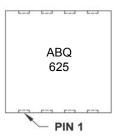
Part Number	Code
MCP14A0451-E/SN	14A0451
MCP14A0451T-E/SN	14A0451
MCP14A0452-E/SN	14A0452
MCP14A0452T-E/SN	14A0452



Example:



Part Number	Code
MCP14A0451T-E/RW	ABQ
MCP14A0452T-E/RW	ABR

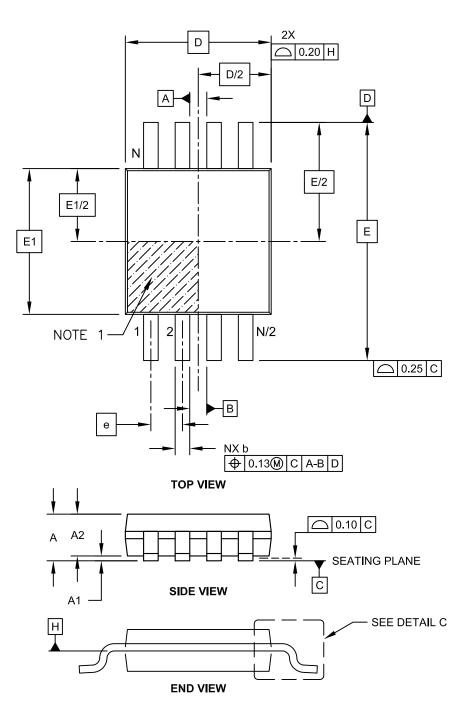


Legend	: XXX Y YY WW NNN @3 *	Customer-specific information Year code (last digit of calendar year) Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code Pb-free JEDEC [®] designator for Matte Tin (Sn) This package is Pb-free. The Pb-free JEDEC designator ((e3)) can be found on the outer packaging for this package.			
Note:					

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8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

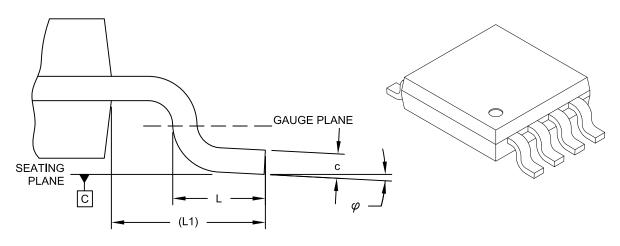
Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Microchip Technology Drawing C04-111C Sheet 1 of 2

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



DETAIL C

	MILLIMETERS			
Dimension Limits		MIN	NOM	MAX
Number of Pins	N	8		
Pitch	е		0.65 BSC	
Overall Height	A	- 1.10		
Molded Package Thickness	A2	0.75 0.85 0.95		
Standoff	A1	0.00 - 0.1		0.15
Overall Width	E	4.90 BSC		
Molded Package Width	E1	3.00 BSC		
Overall Length	D	3.00 BSC		
Foot Length	L	0.40 0.60 0.8		0.80
Footprint	L1	0.95 REF		
Foot Angle	φ	0° - 8		8°
Lead Thickness	С	0.08 - 0.23		0.23
Lead Width	b	0.22 - 0.40		

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

2. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or

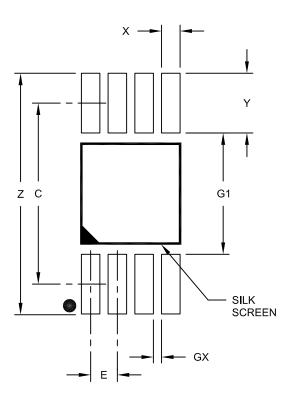
- protrusions shall not exceed 0.15mm per side.
- 3. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances. REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-111C Sheet 2 of 2

8-Lead Plastic Micro Small Outline Package (MS) [MSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

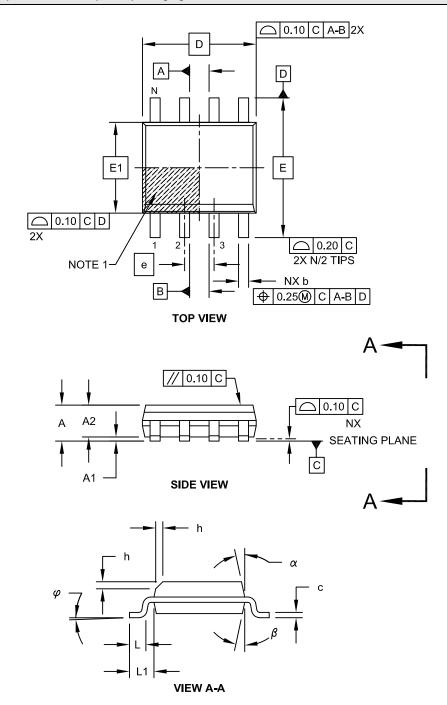
Units		MILLIMETERS			
Dimension Limits		MIN	NOM	MAX	
Contact Pitch	E	0.65 BSC			
Contact Pad Spacing	С	4.40			
Overall Width Z				5.85	
Contact Pad Width (X8) X1				0.45	
Contact Pad Length (X8)				1.45	
Distance Between Pads	G1	2.95			
Distance Between Pads G		0.20			

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2111A



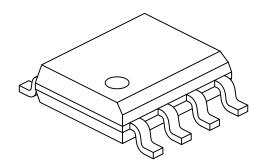
8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging

Microchip Technology Drawing No. C04-057C Sheet 1 of 2

8-Lead Plastic Small Outline (SN) - Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	N	MILLIMETERS			
Dimension Limits		MIN	NOM	MAX	
Number of Pins	Ν	8			
Pitch	е	1.27 BSC			
Overall Height	А	-	-	1.75	
Molded Package Thickness	A2	1.25	-	-	
Standoff §	A1	0.10	-	0.25	
Overall Width	E	6.00 BSC			
Molded Package Width	E1	3.90 BSC			
Overall Length	D	4.90 BSC			
Chamfer (Optional)	h	0.25 - 0.50			
Foot Length	L	0.40 - 1.27		1.27	
Footprint	L1	1.04 REF			
Foot Angle	φ	0°	-	8°	
Lead Thickness	С	0.17	-	0.25	
Lead Width	b	0.31	-	0.51	
Mold Draft Angle Top	lold Draft Angle Top α 5° -		15°		
old Draft Angle Bottom eta 5° -			15°		

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

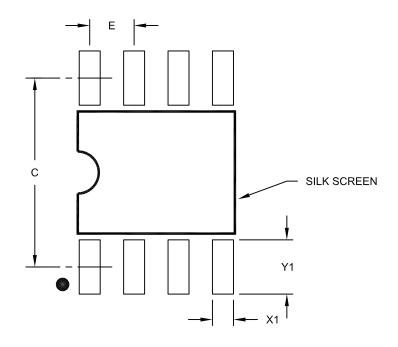
2. § Significant Characteristic

- 3. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15mm per side.
- 4. Dimensioning and tolerancing per ASME Y14.5M BSC: Basic Dimension. Theoretically exact value shown without tolerances. REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing No. C04-057C Sheet 2 of 2

8-Lead Plastic Small Outline (SN) – Narrow, 3.90 mm Body [SOIC]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

Units		MILLIMETERS		
Dimension Limits		MIN	NOM	MAX
Contact Pitch	E		1.27 BSC	
Contact Pad Spacing	С		5.40	
Contact Pad Width (X8)	X1			0.60
Contact Pad Length (X8)	Y1			1.55

Notes:

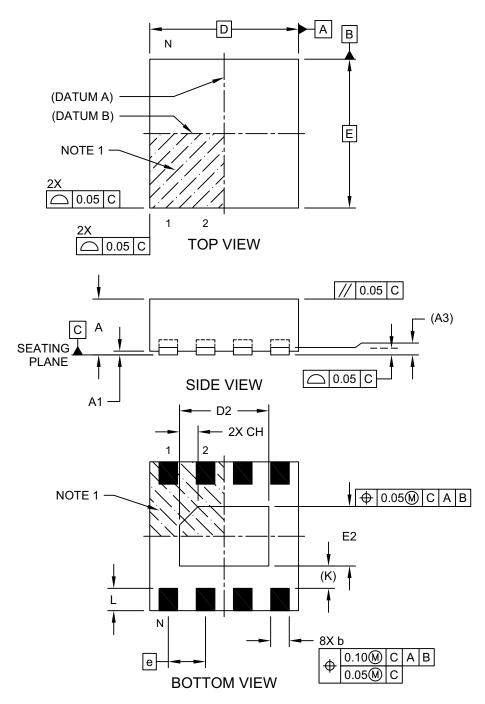
1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2057A

8-Lead Very, Very Thin Plastic Dual Flat, No Lead Package (RW) - 2x2 mm Body [WDFN]

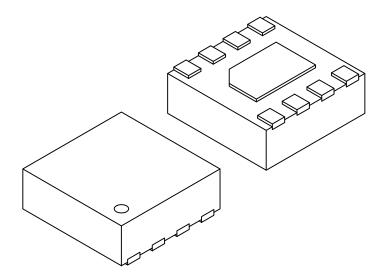
Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



Microchip Technology Drawing C04-261A Sheet 1 of 2

8-Lead Very, Very Thin Plastic Dual Flat, No Lead Package (RW) - 2x2 mm Body [WDFN]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	MILLIMETERS			
Dimension Limits		MIN	NOM	MAX
Number of Terminals	Ν	8		
Pitch	е		0.50 BSC	
Overall Height	Α	0.70 0.75 0.80		
Standoff	A1	0.00 0.02 0.05		
Terminal Thickness	(A3)	0.10 REF		
Overall Width	E	2.00 BSC		
Exposed Pad Width	E2	0.70 0.80 0.90		0.90
Overall Length	D	2.00 BSC		
Exposed Pad Length	D2	1.10 1.20 1.30		1.30
Exposed Pad Chamfer	СН	- 0.25 -		-
Terminal Width	b	0.20 0.25 0.30		0.30
Terminal Length	L	0.25 0.30 0.35		
Terminal-to-Exposed-Pad	(K)	0.30		

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

2. Package is saw singulated

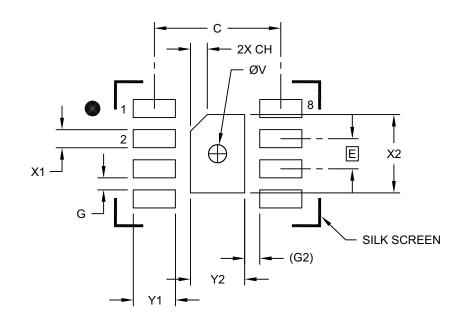
3. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances. REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-261A Sheet 2 of 2

8-Lead Very, Very Thin Plastic Dual Flat, No Lead Package (RW) - 2x2 mm Body [WDFN]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



RECOMMENDED LAND PATTERN

	MILLIMETERS			
Dimension Limits		MIN	NOM	MAX
Contact Pitch	E	0.50 BSC		
Optional Center Pad Width	Y2	0.90		
Optional Center Pad Length	X2			1.30
Contact Pad Spacing	C		2.10	
Center Pad Chamfer CH			0.28	
Contact Pad Width (X8)	X1			0.30
Contact Pad Length (X8)	Y1			0.70
Contact Pad to Contact Pad (X6)	G1	0.20		
Contact Pad to Center Pad (X8)	G1		0.25 REF	
Thermal Via Diameter	V		0.30	

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerances, for reference only.

Microchip Technology Drawing C04-2261A

APPENDIX A: REVISION HISTORY

Revision A (November 2016)

• Original release of this document.

NOTES:

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

PART NO. [X] ⁽¹ Device Tape and	¹⁾ <u>–X /XX</u> I Reel Temperature Package Range	Example a) MCP1	es: I4A0451T-E/MS:	Tape and Reel, Extended temperature, 8LD MSOP package
Device:	MCP14A0451T: High-Speed MOSFET Driver (Tape and Reel) MCP14A0452T: High-Speed MOSFET Driver (Tape and Reel)	,	14A0452T-E/SN: 14A0452T-E/RW:	Extended temperature, 8LD SOIC package
Temperature Range:		Note 1:		identifier only appears in the mber description. This
Package:	MS = Plastic Micro Small Outline Package (MSOP),8-lead 8-lead SN = Plastic Small Outline Package (SOIC), 8-lead RW = Plastic Dual Flat, No Lead Package - 2 x 2 mm Body (WDFN) 8-lead		is not printed o with your Micro	ed for ordering purposes and in the device package. Check ichip Sales Office for package in the Tape and Reel option.

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